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| Soggetti | Artificial intelligence |
| | Pattern recognition |
| | Application software |
| | Database management |
| | Algorithms |
| | Data mining |
| | Artificial Intelligence |
| | Pattern Recognition |
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| | Database Management |
| | Algorithm Analysis and Problem Complexity Data Mining and Knowledge Discovery |
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| Note generali | Includes index. |
| Nota di contenuto | Dimensionality reduction Manifold learning and embedding methodsDissimilarity representations Graph-theoretic methods Model selection, classification and clustering Semi and fully supervised learning methods Shape analysis Spatio-temporal pattern recognition Structural matching Text and document analysis |

This book constitutes the proceedings of the Joint IAPR International Workshop on Structural Syntactic, and Statistical Pattern Recognition, S+SSPR 2016, consisting of the International Workshop on Structural and Syntactic Pattern Recognition SSPR, and the International Workshop on Statistical Techniques in Pattern Recognition, SPR. The 51 full papers presented were carefully reviewed and selected from 68 submissions. They are organized in the following topical sections: dimensionality reduction, manifold learning and embedding methods; dissimilarity representations; graph-theoretic methods; model selection, classification and clustering; semi and fully supervised learning methods; shape analysis; spatio-temporal pattern recognition; structural matching; text and document analysis. .